









LMK1D1204, LMK1D1208

SNAS815B - DECEMBER 2020 - REVISED JUNE 2023

LMK1D120x Low Additive Jitter LVDS Buffer

1 Features

- High-performance LVDS clock buffer family with 2 inputs and 4 (2:4) or 8 (2:8) outputs.
- Output frequency up to 2 GHz.
- Supply voltage: 1.71 V to 3.465 V
- Low additive jitter: < maximum 60 fs RMS in 12kHz to 20-MHz at 156.25 MHz
 - Very low phase noise floor: –164 dBc/Hz (typical)
- Very low propagation delay: < 575 ps maximum
- Output skew: 20 ps maximum
- Universal inputs accept LVDS, LVPECL, LVCMOS, LP-HCSL, HCSL and CML inputs
- LVDS reference voltage, V_{AC REF}, available for capacitive-coupled inputs
- Industrial temperature range: -40°C to 105°C
- Packages available:
 - LMK1D1204: 3-mm × 3-mm, 16-pin VQFN
 - LMK1D1208: 5-mm × 5-mm, 28-pin VQFN (RHD)

2 Applications

- Telecommunications and networking
- Medical imaging
- Test and measurement
- Wireless infrastructure
- Pro audio, video and signage

3 Description

The LMK1D120x clock buffer distributes one of two selectable clock inputs (IN0 and IN1) to 4 or 8 pairs of differential LVDS clock outputs (OUT0 through OUT7) with minimum skew for clock distribution. The LMK1D12x family can accept two clock sources into an input multiplexer. The inputs can either be LVDS, LVPECL, LP-HCSL, HCSL, CML or LVCMOS.

The LMK1D12x is specifically designed for driving 50- Ω transmission lines. In case of driving the inputs in single-ended mode, the appropriate bias voltage as shown in Figure 9-6 must be applied to the unused negative input pin.

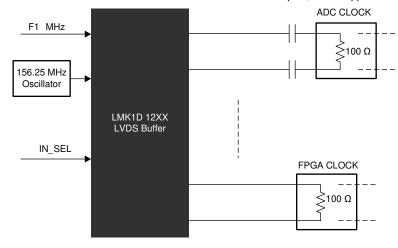
The IN SEL pin selects the input which is routed to the outputs. If this pin is left open, it disables the outputs (logic low). The part supports a fail-safe function. The device further incorporates an input hysteresis which prevents random oscillation of the outputs in the absence of an input signal.

The device operates in 1.8-V or 2.5-V or 3.3-V supply environment and is characterized from -40°C to 105°C (ambient temperature). The LMK1D12x package variant is shown in the table below:

Package Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE (NOM) ⁽²⁾
LMK1D1204	VQFN (16)	3.00 mm × 3.00 mm
LMK1D1208	VQFN (28)	5.00 mm × 5.00 mm

- (1) For all available packages, see the orderable addendum at the end of the data sheet.
- The package size (length × width) is a nominal value and includes pins, where applicable.



Application Example



Table of Contents

1 Features	1	9.3 Feature Description	12
2 Applications		9.4 Device Functional Modes	
3 Description		10 Application and Implementation	. 15
4 Revision History		10.1 Application Information	
5 Device Comparison		10.2 Typical Application	
6 Pin Configuration and Functions	4	10.3 Power Supply Recommendations	18
7 Specifications	6	10.4 Layout	. 19
7.1 Absolute Maximum Ratings		11 Device and Documentation Support	
7.2 ESD Ratings		11.1 Documentation Support	
7.3 Recommended Operating Conditions		11.2 Receiving Notification of Documentation Updates.	
7.4 Electrical Characteristics	6	11.3 Support Resources	. 22
7.5 Typical Characteristics	9	11.4 Trademarks	
8 Parameter Measurement Information		11.5 Electrostatic Discharge Caution	. 22
9 Detailed Description	12	11.6 Glossary	. 22
9.1 Overview		12 Mechanical, Packaging, and Orderable	
9.2 Functional Block Diagram	12	Information	. 22
-			

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (August 2021) to Revision B (June 2023)	Page
Changed table title from: Device Information to: Package Information	
 Added the Device Comparison table for LMK1Dxxxx buffer family of devices Moved the Power Supply Recommendations and Layout sections to the Application and Imp 	
section	
Changes from Revision * (December 2020) to Revision A (August 2021)	Page
First public release	1



5 Device Comparison

Table 5-1. Device Comparison

DEVICE	DEVICE TYPE	FEATURES	OUTPUT SWING	PACKAGE	BODY SIZE	
LMK1D2108	Dual 1:8	Global output enable and swing	350 mV	VOEN (49)	7.00 mm × 7.00 mm	
LIVIK ID2 106	Duai 1.0	control through pin control	500 mV	VQFN (48)	7.00 mm × 7.00 mm	
LMK1D2106	Dual 1:6	Global output enable and swing	350 mV	VQFN (40)	6.00 mm x 6.00 mm	
LWK 1D2 100	Dual 1.0	control through pin control	500 mV	VQFN (40)	0.00 11111 X 0.00 111111	
LMK1D2104	Dual 1:4	Global output enable and swing	350 mV	VQFN (28)	5.00 mm × 5.00 mm	
LWIKTD2104	Duai 1.4	control through pin control	500 mV	VQ(11 (20)	3.00 mm × 3.00 mm	
LMK1D2102	Dual 1:2	Global output enable and swing	350 mV	VQFN (16)	3.00 mm × 3.00 mm	
LIVINTIDZ 102	Duai 1.2	control through pin control	500 mV	VQ(14(10)	5.00 mm ^ 5.00 mm	
LMK1D1216	2:16	Global output enable control	350 mV	VQFN (48)	7.00 mm × 7.00 mm	
LWIKTB1210	2.10	through pin control	500 mV	VQ(14 (+0)	7.00 11111 117.00 111111	
LMK1D1212	2:12	Global output enable control	350 mV	VQFN (40)	6.00 mm × 6.00 mm	
LIVITOTETE	2.12	through pin control	500 mV	VQ114 (+0)	0.00 11111 * 0.00 11111	
LMK1D1208P	2:8	Individual output enable control	350 mV	VQGN (40)	6.00 mm × 6.00 mm	
LIVILY ID 12001	2.0	through pin control	500 mV	VQ0IV (+0)	0.00 11111 * 0.00 11111	
LMK1D1208I	2:8	Individual output enable control	350 mV	VQFN (40)	6.00 mm × 6.00 mm	
EWIKTB 12001	2.0	through I ² C	500 mV	VQ(14 (+0)	0.00 11111 * 0.00 11111	
LMK1D1208	2:8	Global output enable control through pin control	350 mV	VQFN (28)	5.00 mm × 5.00 mm	
LMK1D1204P	2:4	Individual output enable control through pin control	350 mV	VQGN (28)	5.00 mm × 5.00 mm	
LMK1D1204	2:4	Global output enable control through pin control	350 mV	VQFN (16)	3.00 mm × 3.00 mm	



6 Pin Configuration and Functions

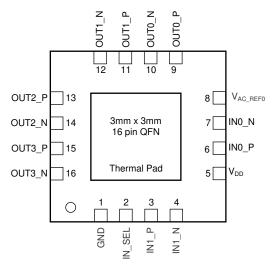


Figure 6-1. LMK1D1204: RGT Package 16-Pin VQFN Top View

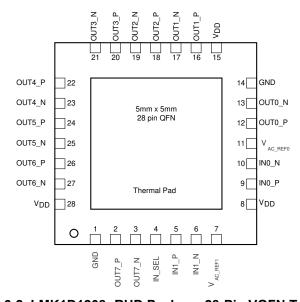


Figure 6-2. LMK1D1208: RHD Package 28-Pin VQFN Top View

Table 6-1. Pin Functions

	PIN		TYPE ⁽¹⁾	DESCRIPTION			
NAME	LMK1D1204	LMK1D1208	I I I PE'	DESCRIPTION			
DIFFERENTIAL/SINGLE	-ENDED CLOCK	INPUT					
IN0_P	6	9		Primary: Differential input pair or single-ended input			
INO_N	7	10	'	Filmary. Differential input pair or single-ended input			
IN1_P	3	5		Secondary: Differential input pair or single-ended input.			
IN1_N	4	6	I	Note that INP0, INN0 are used indistinguishably with IN0_P, IN0_N.			
INPUT SELECT	INPUT SELECT						
IN_SEL	2	4	I	Input Selection with an internal 500-k Ω pullup and 320-k Ω pulldown resistor, selects input port; (See Table 9-1)			

Table 6-1. Pin Functions (continued)

	PIN		- ><(1)	n-conjuntory
NAME	LMK1D1204	LMK1D1208	TYPE ⁽¹⁾	DESCRIPTION
BIAS VOLTAGE OUTPU	JT			
V _{AC_REF0}	8	11	0	Bias voltage output for capacitive coupled inputs. If used, TI
V _{AC_REF1}	_	7] 0	recommends using a 0.1-µF capacitor to GND on this pin.
DIFFERENTIAL CLOCK	OUTPUT			
OUT0_P	9	12		Differential LV/DC cutaut acia aurah ac 0
OUT0_N	10	13	0	Differential LVDS output pair number 0
OUT1_P	11	16		Differential LV/DC cutaut acia aurah and
OUT1_N	12	17	0	Differential LVDS output pair number 1
OUT2_P	13	18	_	Differential LV/DC cutaut acia aurah an 2
OUT2_N	14	19	0	Differential LVDS output pair number 2
OUT3_P	15	20		Differential LV/DC cutaut acia aurah an 2
OUT3_N	16	21	0	Differential LVDS output pair number 3
OUT4_P		22		Differential LV/DC cutaut a circumstant 4
OUT4_N		23	0	Differential LVDS output pair number 4
OUT5_P		24	0	Differential LVDS output pair number 5
OUT5_N	_	25] 0	Differential EVDS output pair number 5
OUT6_P		26	0	Differential LVDS output pair number 6
OUT6_N	<u> </u>	27		Differential LVD3 output pair frumber o
OUT7_P		2	- 0	Differential LVDS output nois number 7
OUT7_N	_	3] 0	Differential LVDS output pair number 7
SUPPLY VOLTAGE	•			
		8		
V_{DD}	5	15	Р	Device Power Supply (1.8V or 2.5V or 3.3V)
		28		
GROUND				
GND	1	1	G	Ground
GIVE		14		Glound
MISC				
DAP	DAP	DAP	GND	Die Attach Pad. Connect to the PCB ground plane for heat dissipation.
NC	_	_	NC	No Connection
	1	1	1	II.

⁽¹⁾ G = Ground, I = Input, O = Output, P = Power



7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

	3 1 3 (MIN	MAX	UNIT
V_{DD}	Supply voltage	-0.3	3.6	V
V _{IN}	Input voltage	-0.3	3.6	V
Vo	Output voltage	-0.3	V _{DD} + 0.3	V
I _{IN}	Input current	-20	20	mA
Io	Continuous output current	-50	50	mA
TJ	Junction temperature		135	°C
T _{stg}	Storage temperature (2)	-65	150	°C

⁽¹⁾ Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

7.2 ESD Ratings

			VALUE	UNIT
V		Human body model (HBM), per ANSI/ESDA/ JEDEC JS-001, all pins ⁽¹⁾	±3000	\/
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per ANSI/ESDA/ JEDEC JS-002, all pins ⁽²⁾	±1000	V

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	NOM	MAX	UNIT
	3.3-V supply	3.135	3.3	3.465		
V_{DD}	Core supply voltage	2.5-V supply	2.375	2.5	2.625	V
		1.8-V supply	1.71	1.8	1.89	
Supply Ramp	Supply voltage ramp	Requires monotonic ramp (10-90% of V_{DD})	0.1		20	ms
T _A	Operating free-air temperature		-40		105	°C
TJ	Operating junction temperature		-40		135	°C

7.4 Electrical Characteristics

 V_{DD} = 1.8 V ± 5 %, -40°C ≤ T_A ≤ 105°C. Typical values are at V_{DD} = 1.8 V, 25°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT			
POWER SUPPLY CHARACTERISTICS									
SINGLE-ENDED LVCMOS/LVTTL CLOCK INPUT (Applies to V _{DD} = 1.8 V ± 5%, 2.5 V ± 5% and 3.3 V ± 5%)									
f _{IN}	Input frequency	Clock input	DC		250	MHz			
V _{IN_S-E}	Single-ended Input Voltage Swing	Assumes a square wave input with two levels	0.4		3.465	V			
dVIN/dt	Input Slew Rate (20% to 80% of the amplitude)		0.05			V/ns			
I _{IH}	Input high current	V _{DD} = 3.465 V, V _{IH} = 3.465 V			50	μΑ			
I _{IL}	Input low current	V _{DD} = 3.465 V, V _{IL} = 0 V	-30			μΑ			

⁽²⁾ Device unpowered

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



 V_{DD} = 1.8 V ± 5 %, -40°C ≤ T_A ≤ 105°C. Typical values are at V_{DD} = 1.8 V, 25°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
C _{IN_SE}	Input capacitance	at 25°C		3.5]	pF
DIFFERENTI	IAL CLOCK INPUT (Applies to V _{DD} = 1.8	V ± 5%, 2.5 V ± 5% and 3.3 V ± 5%)				
f _{IN}	Input frequency	Clock input			2	GHz
	Differential input voltage peak-to-peak	V _{ICM} = 1 V (V _{DD} = 1.8 V)	0.3		2.4	
$V_{IN,DIFF(p-p)}$	{2*(V _{INP} -V _{INN})}	V _{ICM} = 1.25 V (V _{DD} = 2.5 V/3.3 V)	0.3		2.4	V_{PP}
V _{ICM}	Input common mode voltage	V _{IN,DIFF(P-P)} > 0.4 V (V _{DD} = 1.8 V/2.5/3.3 V)	0.25		2.3	V
I _{IH}	Input high current	V _{DD} = 3.465 V, V _{INP} = 2.4 V, V _{INN} = 1.2 V			30	μA
I _{IL}	Input low current	V _{DD} = 3.465 V, V _{INP} = 0 V, V _{INN} = 1.2 V	-30			μΑ
C _{IN_S-E}	Input capacitance (Single-ended)	at 25°C		3.5		pF
	JTPUT CHARACTERISTICS					
V	Steady-state common mode output	$V_{IN,DIFF(P-P)} = 0.3 \text{ V, R}_{LOAD} = 100$ $\Omega \text{ (V}_{DD} = 1.8 \text{ V)}$	1		1.2	V
V _{OC(SS)}	voltage	$V_{IN,DIFF(P-P)} = 0.3 \text{ V}, R_{LOAD} = 100$ $\Omega (V_{DD} = 2.5 \text{ V}/3.3 \text{ V})$	1.1		1.375	v
LVDS AC OL	JTPUT CHARACTERISTICS					
V_{ring}	Output overshoot and undershoot	$V_{IN,DIFF(P-P)} = 0.3 \text{ V, R}_{LOAD} = 100$ $\Omega, f_{OUT} = 491.52 \text{ MHz}$	-0.1		0.1	V_{OD}
I _{OS}	Short-circuit output current (differential)	V _{OUTP} = V _{OUTN}	-12		12	mA
I _{OS(cm)}	Short-circuit output current (common-mode)	V _{OUTP} = V _{OUTN} = 0	-24		24	mA
t _{PD}	Propagation delay	$V_{IN,DIFF(P-P)} = 0.3 \text{ V, } R_{LOAD} = 100$ $\Omega^{(2)}$	0.3		0.575	ns
t _{SK, PP}	Part-to-part skew	Skew between outputs on different parts subjected to the same operating conditions with the same input and output loading.			250	ps
t _{SK, P}	Pulse skew	50% duty cycle input, crossing point-to-crossing-point distortion (4)	-20		20	ps
t _{RJIT(ADD)}	Random additive Jitter (rms)	f_{IN} = 156.25 MHz with 50% dutycycle, Input slew rate = 1.5V/ns, Integration range = 12 kHz – 20 MHz, with output load R _{LOAD} = 100 Ω		50	60	fs, RMS
		PN _{1kHz}		-143		
	Phase Noise for a carrier frequency of	PN _{10kHz}		-152		
Phase noise	156.25 MHz with 50% duty-cycle, Input slew rate = 1.5V/ns with output load	PN _{100kHz}		-157		dBc/Hz
	$R_{LOAD} = 100 \Omega$	PN _{1MHz}		-160		
		PN _{floor}		-164		
MUX _{ISO}	Mux Isolation	f_{IN} = 156.25 MHz. The difference in power level at f_{IN} when the selected clock is active and the unselected clock is static versus when the selected clock is inactive and the unselected clock is active.		80		dB
ODC	Output duty cycle	With 50% duty cycle input	45		55	%
t _R /t _F	Output rise and fall time	20% to 80% with R_{LOAD} = 100 Ω			300	ps
V _{AC_REF}	Reference output voltage	VDD = 2.5 V, I _{LOAD} = 100 μA	0.9	1.25	1.375	V



 V_{DD} = 1.8 V ± 5 %, -40°C ≤ T_A ≤ 105°C. Typical values are at V_{DD} = 1.8 V, 25°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
PSNR	Power Supply Noise Rejection (f _{carrier} =	10 kHz, 100 mVpp ripple injected on V _{DD}		-70	dBc	
FOINIX	156.25 MHz)	1 MHz, 100 mVpp ripple injected on V _{DD}		-50		dbc

- (1) Measured between single-ended/differential input crossing point to the differential output crossing point.
- (2) Defined as the magnitude of the time difference between the high-to-low and low-to-high propagation delay times at an output.

7.5 Typical Characteristics

The Figure 7-1 captures the variation of the LMK1D1208 current consumption with input frequency and supply voltage. The LMK1D1204 follows a similar trend. Figure 7-2 shows the variation of the differential output voltage (VOD) swept across frequency. This result is applicable to LMK1D1204 as well.

It is important to note that Figure 7-1 and Figure 7-2 serve as a guidance to the users on what to expect for the range of operating frequency supported by LMK1D120x. It is crucial to note that these graphs were plotted for a limited number of frequencies and load conditions which may not represent the customer system.

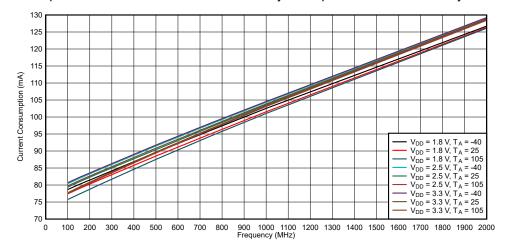


Figure 7-1. LMK1D1208 Current Consumption vs. Frequency

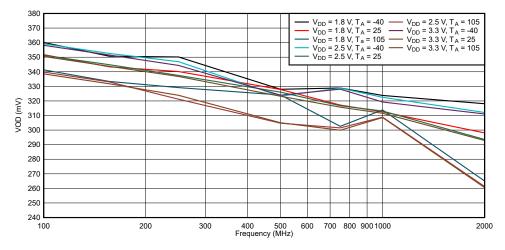


Figure 7-2. LMK1D1208 VOD vs. Frequency



8 Parameter Measurement Information

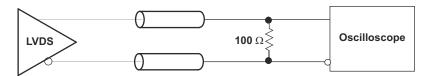


Figure 8-1. LVDS Output DC Configuration During Device Test

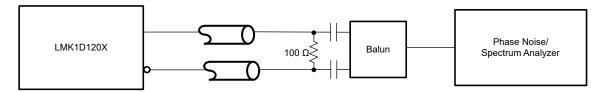


Figure 8-2. LVDS Output AC Configuration During Device Test

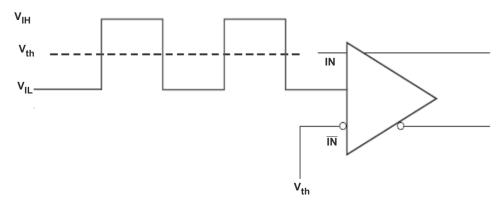


Figure 8-3. DC-Coupled LVCMOS Input During Device Test

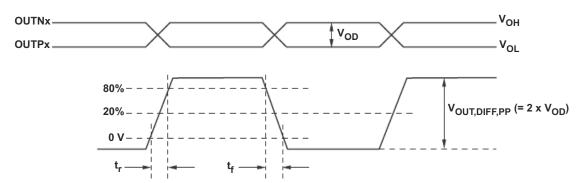
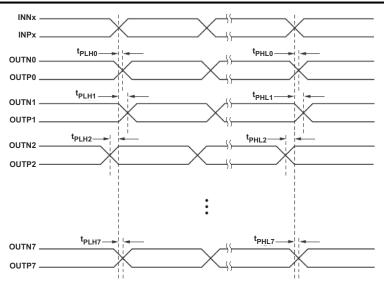


Figure 8-4. Output Voltage and Rise/Fall Time



- A. Output skew is calculated as the greater of the following: the difference between the fastest and the slowest t_{PLHn} or the difference between the fastest and the slowest t_{PHLn} (n = 0, 1, 2, ...7)
- B. Part to part skew is calculated as the greater of the following: the difference between the fastest and the slowest t_{PLHn} or the difference between the fastest and the slowest t_{PHLn} across multiple devices (n = 0, 1, 2, ..7)

Figure 8-5. Output Skew and Part-to-Part Skew

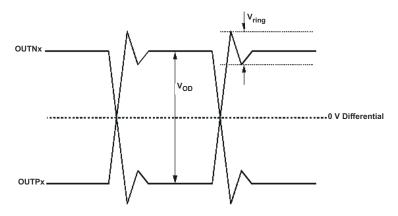


Figure 8-6. Output Overshoot and Undershoot

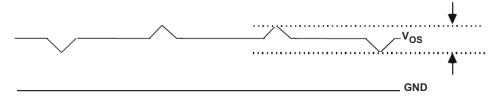


Figure 8-7. Output AC Common Mode



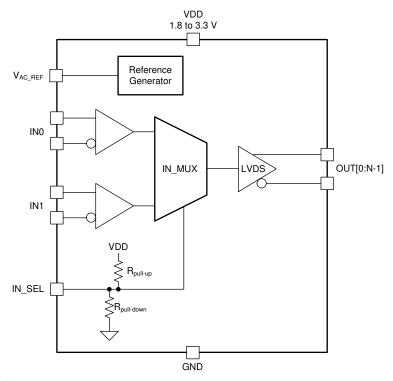
9 Detailed Description

9.1 Overview

The LMK1D120x LVDS drivers use CMOS transistors to control the output current. Therefore, proper biasing and termination are required to ensure correct operation of the device and to maximize signal integrity.

The proper LVDS termination for signal integrity over two $50-\Omega$ lines is $100~\Omega$ between the outputs on the receiver end. Either DC-coupled termination or AC-coupled termination can be used for LVDS outputs. TI recommends placing a termination resistor close to the receiver. If the receiver is internally biased to a voltage different than the output common-mode voltage of the LMK1D12XX, AC-coupling must be used. If the LVDS receiver has internal $100-\Omega$ termination, external termination must be omitted.

9.2 Functional Block Diagram



9.3 Feature Description

The LMK1D120x is a low additive jitter LVDS fan-out buffer that can generate up to eight copies of two selectable LVPECL, LVDS, LP-HCSL, HCSL or LVCMOS inputs. The LMK1D120x can accept reference clock frequencies up to 2 GHz while providing low output skew.

9.3.1 Fail-Safe Input and Hysteresis

The LMK1D120x family of devices is designed to support fail-safe input operation feature. This feature allows the user to drive the device inputs before V_{DD} is applied without damaging the device. Refer to *Specifications* for more information on the maximum input supported by the device. User should note that incorporating the fail-safe inputs also results in a slight increase in clock input pin capacitance.

The device also incorporates an input hysteresis which prevents random oscillation in absence of an input signal. Furthermore, this feature allows the input pins to be left open.

9.3.2 Input Mux

The LMK1D120x family of devices has a 2:1 input mux. This feature allows the user to select between the two clock inputs (using the IN_SEL pin) to the device and fan it out to the outputs. More information on the input selection is provided in the next section.



9.4 Device Functional Modes

The two inputs of the LMK1D120x are internally muxed together and can be selected through the control pin (see Table 9-1). Unused input can be left floating thus reducing the need for additional components. Both AC-and DC-coupling schemes can be used with the LMK1D120x to provide greater system flexibility.

Table 9-1. Input Selection Table

IN_SEL	ACTIVE CLOCK INPUT
0	INO_P, INO_N
1	IN1_P, IN1_N
Open	None (1)

 The input buffers are disabled and the outputs are static logic low.

9.4.1 LVDS Output Termination

TI recommends unused outputs to be terminated differentially with a $100-\Omega$ resistor for optimum performance, although unterminated outputs are also okay but will result in slight degradation in performance (Output AC common-mode V_{OS}) in the outputs being used.

The LMK1D120x can be connected to LVDS receiver inputs with DC- and AC-coupling as shown in Figure 9-1 and Figure 9-2 (respectively).

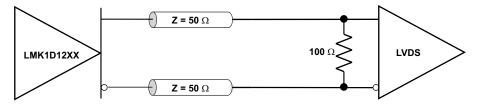


Figure 9-1. Output DC Termination

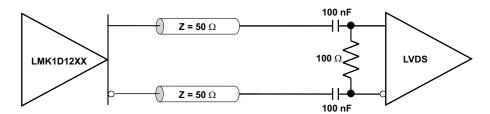


Figure 9-2. Output AC Termination (With the Receiver Internally Biased)

9.4.2 Input Termination

The LMK1D120x input stage is designed with flexibility in mind to allow the user to drive the device with a wide variety of signal types. This device can be interfaced with LVDS, LVPECL, LP-HCSL, HCSL, CML or LVCMOS drivers. Please refer to *Electrical Characteristics* for more details.

LVDS drivers can be connected to LMK1D120x inputs with DC- and AC-coupling as shown Figure 9-3 and Figure 9-4 (respectively).

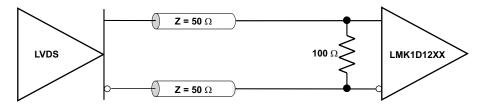


Figure 9-3. LVDS Clock Driver Connected to LMK1D120x Input (DC-Coupled)



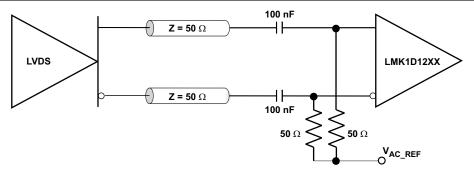


Figure 9-4. LVDS Clock Driver Connected to LMK1D120x Input (AC-Coupled)

Figure 9-5 shows how to connect LVPECL inputs to the LMK1D120x. The series resistors are required to reduce the LVPECL signal swing if the signal swing is $>1.6 \text{ V}_{PP}$.

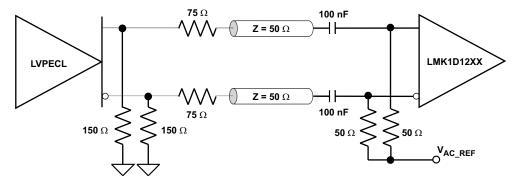


Figure 9-5. LVPECL Clock Driver Connected to LMK1D120x Input

Figure 9-6 illustrates how to couple a LVCMOS clock input to the LMK1D120x directly.

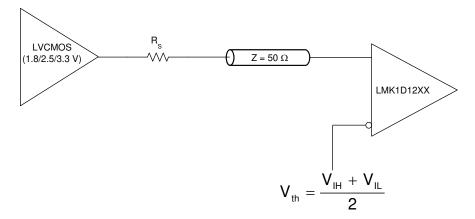


Figure 9-6. 1.8-V/2.5-V/3.3-V LVCMOS Clock Driver Connected to LMK1D120x Input

For unused input, TI recommends grounding both input pins (INP, INN) using 1-k Ω resistors.



10 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

10.1 Application Information

The LMK1D120x is a low additive jitter universal to LVDS fan-out buffer with 2 selectable inputs. The small package, low output skew, and low additive jitter make for a flexible device in demanding applications.

10.2 Typical Application

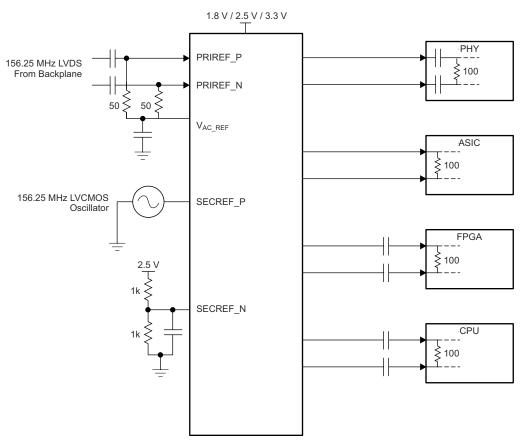


Figure 10-1. Fan-Out Buffer for Line Card Application



10.2.1 Design Requirements

The LMK1D120x shown in Figure 10-1 is configured to select two inputs: a 156.25-MHz LVDS clock from the backplane, or a secondary 156.25-MHz LVCMOS 2.5-V oscillator. The LVDS clock is AC-coupled and biased using the integrated reference voltage generator. A resistor divider is used to set the threshold voltage correctly for the LVCMOS clock. $0.1-\mu F$ capacitors are used to reduce noise on both V_{AC_REF} and SECREF_N. Either input signal can be then fanned out to desired devices, as shown. The configuration example is driving 4 LVDS receivers in a line card application with the following properties:

- The PHY device is capable of DC-coupling with an LVDS driver such as the LMK1D120x. This PHY device features internal termination so no additional components are required for proper operation.
- The ASIC LVDS receiver features internal termination and operates at the same common-mode voltage as the LMK1D120x. Again, no additional components are required.
- The FPGA requires external AC-coupling, but has internal termination. 0.1-µF capacitors are placed to provide AC-coupling. Similarly, the CPU is internally terminated, and requires only external AC-coupling capacitors.
- Unused outputs of the LMK1D device are terminated differentially with a 100-Ω resistor for optimum performance.

10.2.2 Detailed Design Procedure

See *Input Termination* for proper input terminations, dependent on single-ended or differential inputs.

See LVDS Output Termination for output termination schemes depending on the receiver application.

TI recommends unused outputs to be terminated differentially with a $100-\Omega$ resistor for optimum performance, although unterminated outputs are also okay but will result in slight degradation in performance (Output AC common-mode V_{OS}) in the outputs being used.

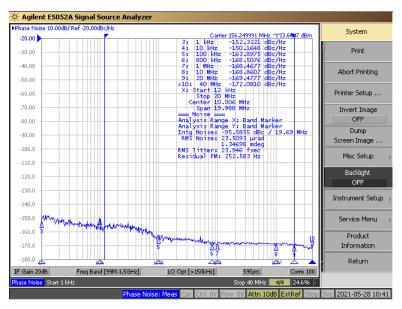
In this example, the PHY, ASIC, and FPGA or CPU require different schemes. Power-supply filtering and bypassing is critical for low-noise applications.

See *Power Supply Recommendations* for recommended filtering techniques. A reference layout is provided in *Low-Additive Jitter, Four LVDS Outputs Clock Buffer Evaluation Board* (SCAU043).

Submit Document Feedback

10.2.3 Application Curves

The LMK1D1208's low additive noise is shown below. The low noise 156.25-MHz source with 24-fs RMS jitter shown in Figure 10-2 drives the LMK1D1208, resulting in 46.4-fs RMS when integrated from 12 kHz to 20 MHz (Figure 10-3). The resultant additive jitter is a low 39.7-fs RMS for this configuration. Note that this result applies to the LMK1D1204 device as well.



A. Reference signal is low-noise Rohde and Schwarz SMA100B

Figure 10-2. LMK1D208 Reference Phase Noise, 156.25 MHz, 24-fs RMS (12 kHz to 20 MHz)

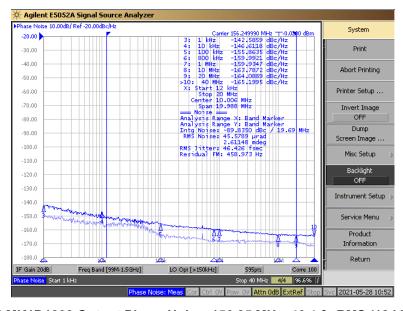


Figure 10-3. LMK1D1208 Output Phase Noise, 156.25 MHz, 46.4-fs RMS (12 kHz to 20 MHz)

The Figure 10-4 captures the low close-in phase noise of the LMK1D1208 device. The LMK1D1204 and LMK1D1208 have excellent flicker noise as a result of superior process technology and design. This enables their use for clock distribution in radar systems, medical imaging systems etc which require ultra-low close-in phase noise clocks.

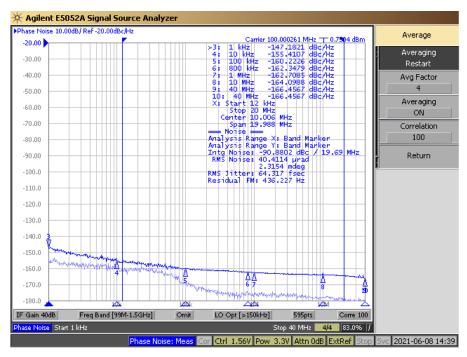


Figure 10-4. LMK1D1208 Output Phase Noise, 100 MHz, 1 kHz offset: -147 dBc/Hz

10.3 Power Supply Recommendations

High-performance clock buffers are sensitive to noise on the power supply, which can dramatically increase the additive jitter of the buffer. Thus, it is essential to reduce noise from the system power supply, especially when jitter or phase noise is critical to applications.

Filter capacitors are used to eliminate the low-frequency noise from the power supply, where the bypass capacitors provide the low impedance path for high-frequency noise and guard the power-supply system against the induced fluctuations. These bypass capacitors also provide instantaneous current surges as required by the device and must have low equivalent series resistance (ESR). To properly use the bypass capacitors, they must be placed close to the power-supply pins and laid out with short loops to minimize inductance. TI recommends adding as many high-frequency (for example, 0.1-µF) bypass capacitors as there are supply pins in the package. TI recommends, but does not require, inserting a ferrite bead between the board power supply and the chip power supply that isolates the high-frequency switching noises generated by the clock driver; these beads prevent the switching noise from leaking into the board supply. Choose an appropriate ferrite bead with low DC-resistance because it is imperative to provide adequate isolation between the board supply and the chip supply, as well as to maintain a voltage at the supply pins that is greater than the minimum voltage required for proper operation.

Figure 10-5 shows this recommended power-supply decoupling method.



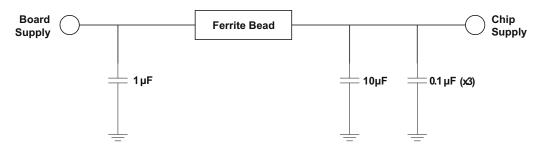


Figure 10-5. Power Supply Decoupling

10.4 Layout

10.4.1 Layout Guidelines

For reliability and performance reasons, the die temperature must be limited to a maximum of 135°C.

The device package has an exposed pad that provides the primary heat removal path to the printed circuit board (PCB). To maximize the heat dissipation from the package, a thermal landing pattern including multiple vias to a ground plane must be incorporated into the PCB within the footprint of the package. The thermal pad must be soldered down to ensure adequate heat conduction to of the package. Figure 10-6 shows a recommended land and via pattern for LMK1D1208.



10.4.2 Layout Example

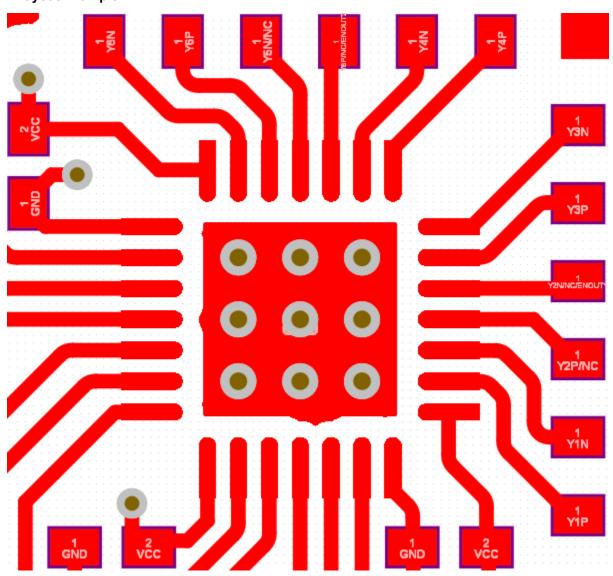


Figure 10-6. Recommended PCB Layout, Top Layer



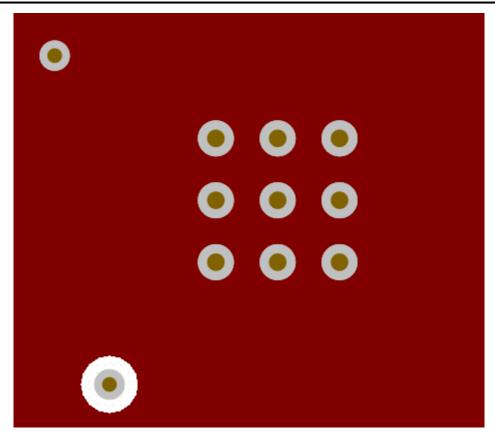


Figure 10-7. PCB Layout, GND Layer



11 Device and Documentation Support

11.1 Documentation Support

11.1.1 Related Documentation

For related documentation see the following:

- Low-Additive Jitter, Four LVDS Outputs Clock Buffer Evaluation Board (SCAU043)
- Power Consumption of LVPECL and LVDS (SLYT127)
- Semiconductor and IC Package Thermal Metrics (SPRA953)
- Using Thermal Calculation Tools for Analog Components (SLUA556)

11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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11.4 Trademarks

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11.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
LMK1D1204RGTR	Active	Production	VQFN (RGT) 16	3000 LARGE T&R	Yes	FULL NIPDAU	Level-1-260C-UNLIM	-40 to 105	LD1204
LMK1D1204RGTR.B	Active	Production	VQFN (RGT) 16	3000 LARGE T&R	Yes	FULL NIPDAU	Level-1-260C-UNLIM	-40 to 105	LD1204
LMK1D1204RGTRG4	Active	Production	VQFN (RGT) 16	3000 LARGE T&R	Yes	FULL NIPDAU	Level-1-260C-UNLIM	-40 to 105	LD1204
LMK1D1204RGTRG4.B	Active	Production	VQFN (RGT) 16	3000 LARGE T&R	Yes	FULL NIPDAU	Level-1-260C-UNLIM	-40 to 105	LD1204
LMK1D1204RGTT	Active	Production	VQFN (RGT) 16	250 SMALL T&R	Yes	FULL NIPDAU	Level-1-260C-UNLIM	-40 to 105	LD1204
LMK1D1204RGTT.B	Active	Production	VQFN (RGT) 16	250 SMALL T&R	Yes	FULL NIPDAU	Level-1-260C-UNLIM	-40 to 105	LD1204
LMK1D1208RHDR	Active	Production	VQFN (RHD) 28	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	LMK1D 1208
LMK1D1208RHDR.B	Active	Production	VQFN (RHD) 28	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	LMK1D 1208
LMK1D1208RHDT	Active	Production	VQFN (RHD) 28	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	LMK1D 1208
LMK1D1208RHDT.B	Active	Production	VQFN (RHD) 28	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	LMK1D 1208
LMK1D1208RHDTG4	Active	Production	VQFN (RHD) 28	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	LMK1D 1208
LMK1D1208RHDTG4.B	Active	Production	VQFN (RHD) 28	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	LMK1D 1208

⁽¹⁾ Status: For more details on status, see our product life cycle.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.



PACKAGE OPTION ADDENDUM

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(6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

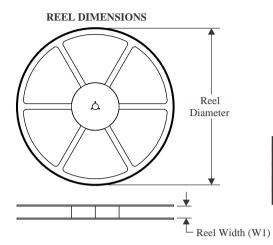
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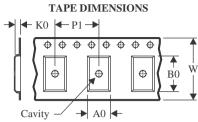
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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

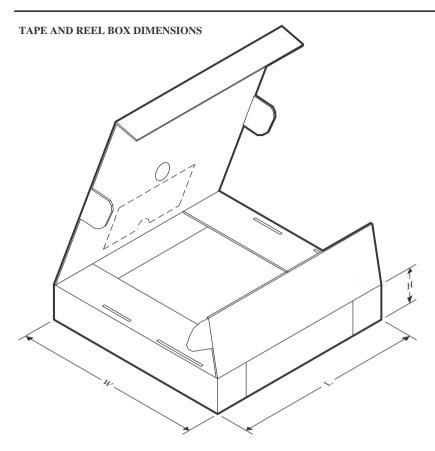


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMK1D1204RGTR	VQFN	RGT	16	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
LMK1D1204RGTRG4	VQFN	RGT	16	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
LMK1D1204RGTT	VQFN	RGT	16	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
LMK1D1208RHDR	VQFN	RHD	28	3000	330.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2
LMK1D1208RHDT	VQFN	RHD	28	250	180.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2
LMK1D1208RHDTG4	VQFN	RHD	28	250	180.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2

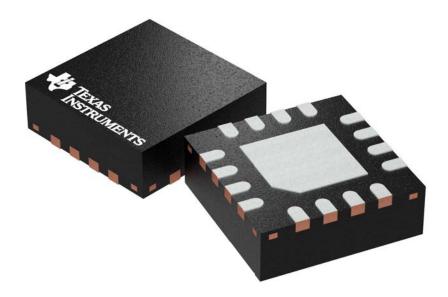


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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMK1D1204RGTR	VQFN	RGT	16	3000	367.0	367.0	35.0
LMK1D1204RGTRG4	VQFN	RGT	16	3000	367.0	367.0	35.0
LMK1D1204RGTT	VQFN	RGT	16	250	210.0	185.0	35.0
LMK1D1208RHDR	VQFN	RHD	28	3000	367.0	367.0	35.0
LMK1D1208RHDT	VQFN	RHD	28	250	210.0	185.0	35.0
LMK1D1208RHDTG4	VQFN	RHD	28	250	210.0	185.0	35.0

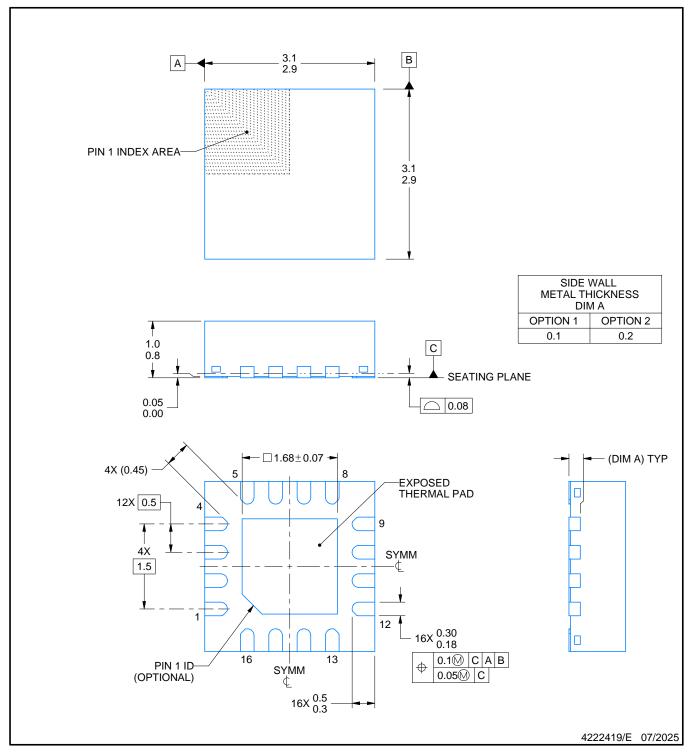


Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





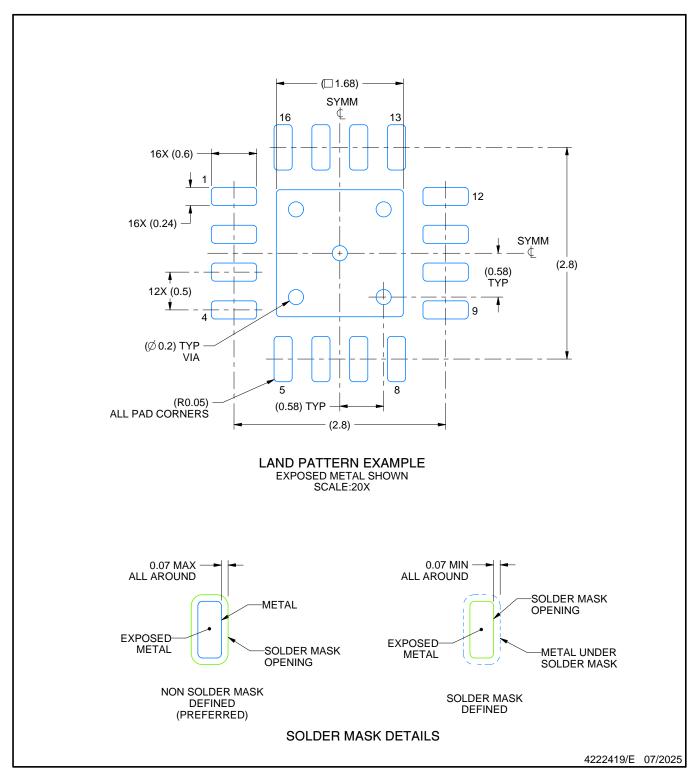




NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

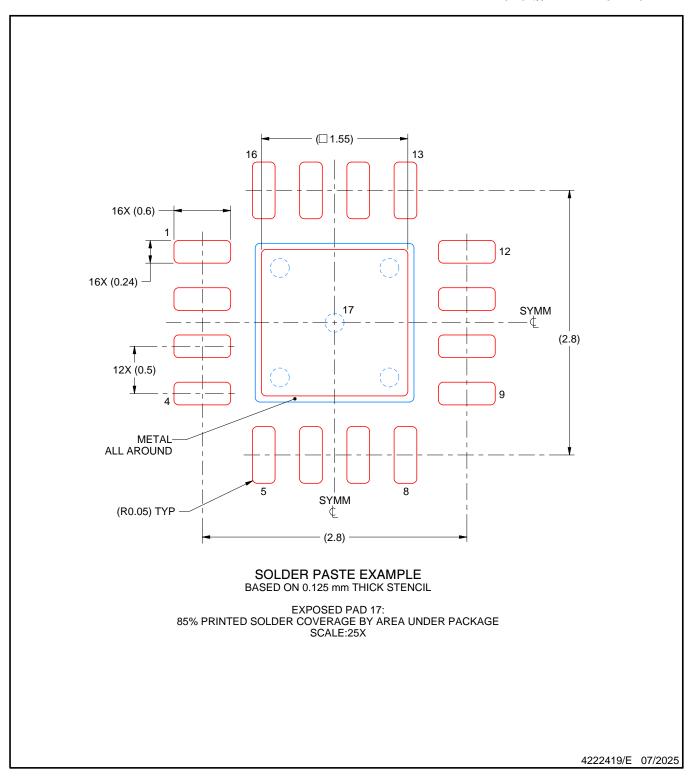




NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.





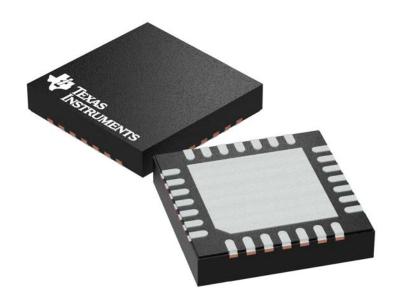
NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



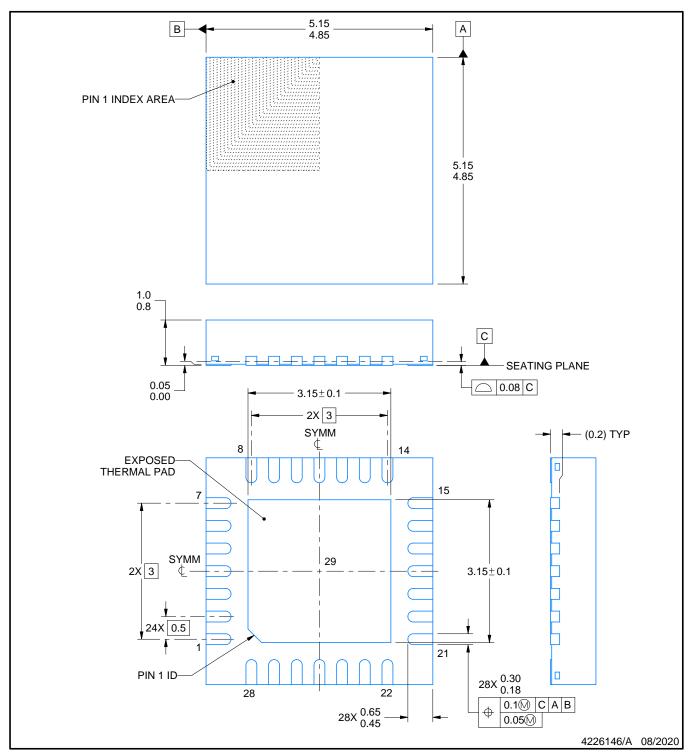
5 x 5 mm, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD



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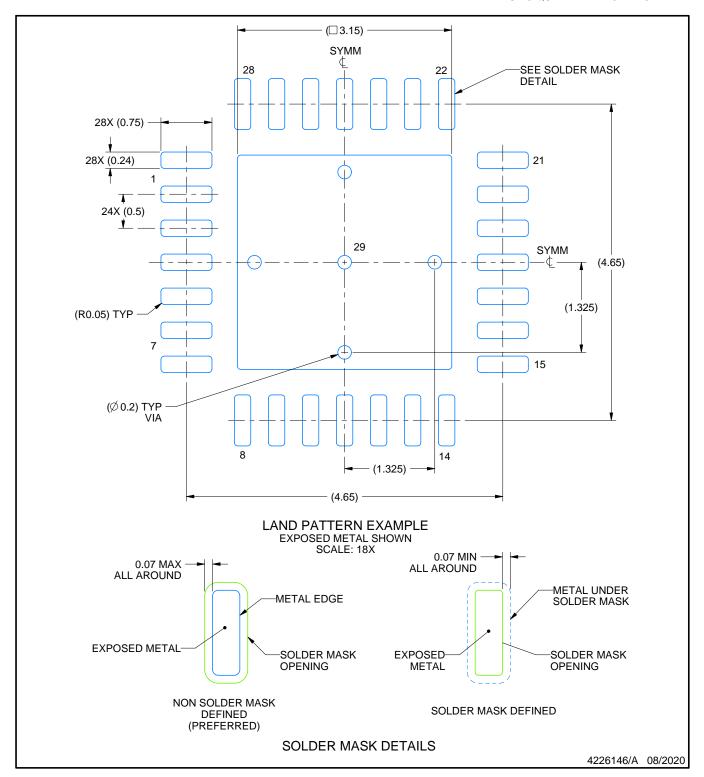




NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
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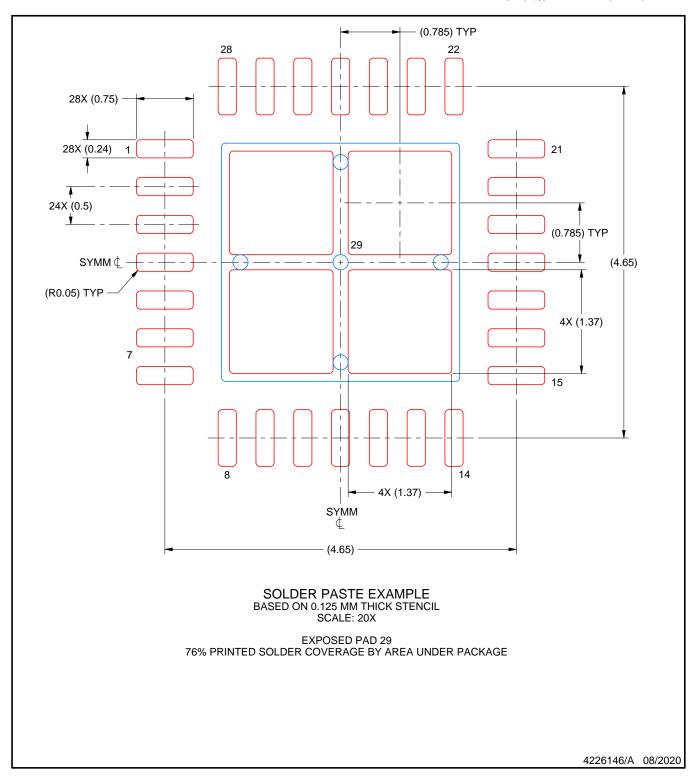




NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.





NOTES: (continued)

^{6.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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